Field Stop Trench IGBT 650 V, 75 A

AFGHL75T65SQD

Using the novel field stop 4th generation high speed IGBT technology. AFGHL75T65SQD which is AEC Q101 qualified offers the optimum performance for both hard and soft switching topology in automotive application.

Features

- AEC-Q101 Qualified
- Maximum Junction Temperature: T_I = 175°C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.6 \text{ V (Typ.)} @ I_C = 75 \text{ A}$
- 100% of the Parts are Tested for I_{LM} (Note 2)
- Fast Switching
- Tight Parameter Distribution
- RoHS Compliant

Typical Applications

- Automotive HEV-EV Onboard Chargers
- Automotive HEV-EV DC-DC Converters
- Totem Pole Bridgeless PFC

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-to-Emitter Voltage	V_{CES}	650	V
Gate-to-Emitter Voltage Transient Gate-to-Emitter Voltage	V _{GES}	±20 ±30	V
Collector Current (Note 1) @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	I _C	80 75	Α
Pulsed Collector Current (Note 2)	I _{LM}	300	Α
Pulsed Collector Current (Note 3)	I _{CM}	300	Α
Diode Forward Current @ $T_{C=} 25^{\circ}C$ @ $T_{C=} 100^{\circ}C$	I _F	80 50	Α
Pulsed Diode Maximum Forward Current	I _{FM(2)}	300	Α
Maximum Power Dissipation @ T _C = 25°C @ T _C = 100°C	P _D	375 188	W
Operating Junction / Storage Temperature Range	T _J , T _{STG}	-55 to +175	°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

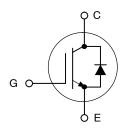
- 1. Value limit by bond wire
- 2. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 300 A, R_{G} = 15 Ω , Inductive Load
- 3. Repetitive Rating: pulse width limited by max. Junction temperature



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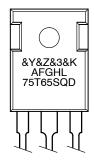
www.onsemi.com

75 A, 650 V V_{CESat} = 1.6 V





MARKING DIAGRAM



&Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = 3-Digit Data Code &K = 2-Digit Lot Traceability Code

ORDERING INFORMATION

AFGHL75T65SQD = Specific Device Code

Device	Package	Shipping
AFGHL75T65SQD	TO-247-3L	30 Units / Rail

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ hetaJC}$	0.4	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ hetaJC}$	0.65	°C/W
Thermal resistance junction-to-ambient	$R_{ hetaJA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		-	•		•	
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V},$ $I_C = 1 \text{ mA}$	BV _{CES}	650	-	_	V
Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	-	0.6	-	V/°C
Collector-emitter cut-off current, gate-emitter short-circuited	V _{GE} = 0 V, V _{CE} = 650 V	I _{CES}	-	-	250	μΑ
Gate leakage current, collector-emitter short-circuited	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	-	±400	nA
ON CHARACTERISTICS						
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 75 \text{ mA}$	V _{GE(th)}	3.4	4.9	6.4	V
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 75 A V _{GE} = 15 V, I _C = 75 A, T _J = 175°C	V _{CE(sat)}	- -	1.6 1.95	2.1 -	V
DYNAMIC CHARACTERISTICS		•			•	
Input capacitance	V _{CE} = 30 V,	C _{ies}	_	4617	-	pF
Output capacitance	V _{GE} = 0 V, f = 1 MHz	C _{oes}	_	152	-	1
Reverse transfer capacitance		C _{res}	_	13	_	1
Gate charge total	V _{CE} = 400 V,	Q_g	_	136	-	nC
Gate-to-emitter charge	I _C = 75 A, V _{GE} = 15 V	Q _{ge}	-	25	-	1
Gate-to-collector charge		Q _{gc}	-	32	-	1
SWITCHING CHARACTERISTICS, INDUC	TIVE LOAD					
Turn-on delay time	T _C = 25°C,	t _{d(on)}	_	23	-	ns
Rise time	V _{CC} = 400 V, I _C = 37.5 A,	t _r	-	17	-	1
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	112	-	1
Fall time	Inductive Load	t _f	-	8	-	1
Turn-on switching loss		E _{on}	_	0.61	-	mJ
Turn-off switching loss		E _{off}	_	0.21	_	1
Total switching loss		E _{ts}	_	0.82	-	1
Turn-on delay time	T _C = 25°C,	t _{d(on)}	_	25	_	ns
Rise time	$V_{CC} = 400 \text{ V},$ $I_{C} = 75 \text{ A},$	t _r	_	46	_	1
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	106	-	1
Fall time	Inductive Load	t _f	_	67	-	1
Turn-on switching loss		E _{on}	-	1.86	-	mJ
Turn-off switching loss		E _{off}	_	1.13	-	1
Total switching loss		E _{ts}	_	2.99	-	1

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS, INI	DUCTIVE LOAD		<u>.</u>	•	•	<u>.e.</u>
Turn-on delay time	T _C = 175°C,	t _{d(on)}	_	21	_	ns
Rise time	V _{CC} = 400 V, I _C = 37.5 A,	t _r	_	19	_	1
Turn-off delay time	$R_G = 4.7 \Omega,$ $V_{GE} = 15 V,$	t _{d(off)}	_	126	_	1
Fall time	Inductive Load	t _f	_	7	_	1
Turn-on switching loss	-	E _{on}	-	1.20	-	mJ
Turn-off switching loss	-	E _{off}	-	0.41	-	
Total switching loss	-	E _{ts}	-	1.61	-	
Turn-on delay time	T _C = 175°C,	t _{d(on)}	-	24	-	ns
Rise time	V _{CC} = 400 V, I _C = 75 A,	t _r	-	46	-	
Turn-off delay time	$R_G = 4.7 \Omega,$ $V_{GF} = 15 V,$	t _{d(off)}	-	115	-	
Fall time	Inductive Load	t _f	-	72	-	
Turn-on switching loss	-	E _{on}	-	2.84	-	mJ
Turn-off switching loss	-	E _{off}	_	1.35	-	
Total switching loss	-	E _{ts}	_	4.20	-	
DIODE CHARACTERISTICS						
Diode Forward Voltage	I _F = 50 A, T _C = 25°C	V_{FM}	_	2.0	2.6	V
	I _F = 50 A, T _C = 175°C		_	1.64	_	1
Reverse Recovery Energy	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/s}, T_C = 175^{\circ}\text{C}$	E _{rec}	-	52	-	μJ
Diode Reverse Recovery Time	I _F = 50 A, dI _F /dt = 200 A/s, T _C = 25°C	T _{rr}	_	36	_	ns
	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/s}, T_C = 175^{\circ}\text{C}$		_	200	_	
Diode Reverse Recovery Charge	I _F = 50 A, dI _F /dt = 200 A/s, T _C = 25°C	Q _{rr}	_	54	_	nC
	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/s}, T_C = 175^{\circ}\text{C}$		_	954	-	1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

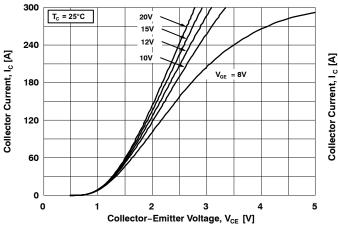


Figure 1. Typical Output Characteristics $(T_{.I} = 25^{\circ}C)$

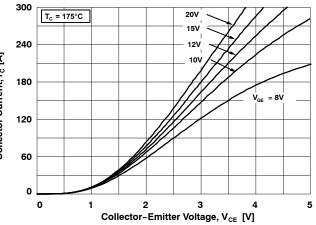


Figure 2. Typical Output Characteristics $(T_{.1} = 175^{\circ}C)$

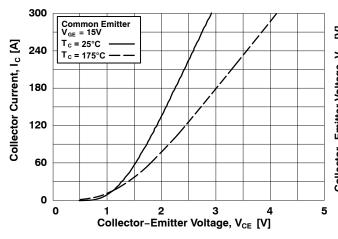


Figure 3. Typical Saturation Voltage Characteristics

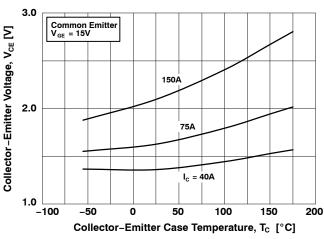


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

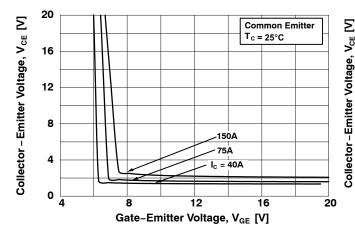


Figure 5. Saturation Voltage vs. V_{GE} ($T_J = 25^{\circ}C$)

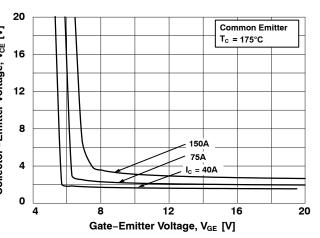


Figure 6. Saturation Voltage vs. V_{GE} (T_J = 175°C)

TYPICAL CHARACTERISTICS (continued)

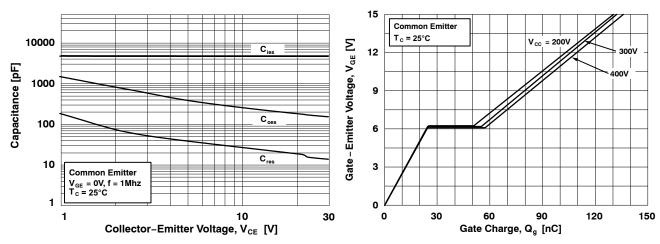


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics

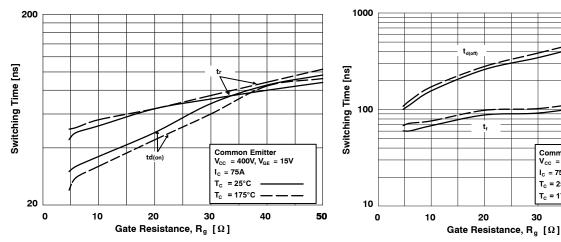


Figure 9. Turn-On Characteristics vs. Gate Resistance

Figure 10. Turn-Off Characteristics vs. Gate Resistance

Common Emitter $V_{CC} = 400V, V_{GE} = 15V,$

40

50

I_C = 75A

T_C = 25°C

T_C = 175°C

30

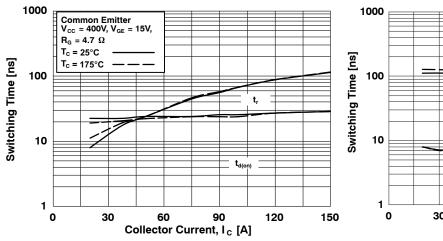


Figure 11. Turn-On Characteristics vs. Collector Current

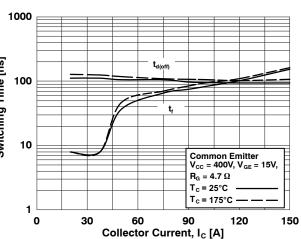


Figure 12. Turn-Off Characteristics vs. Collector Current

TYPICAL CHARACTERISTICS (continued)

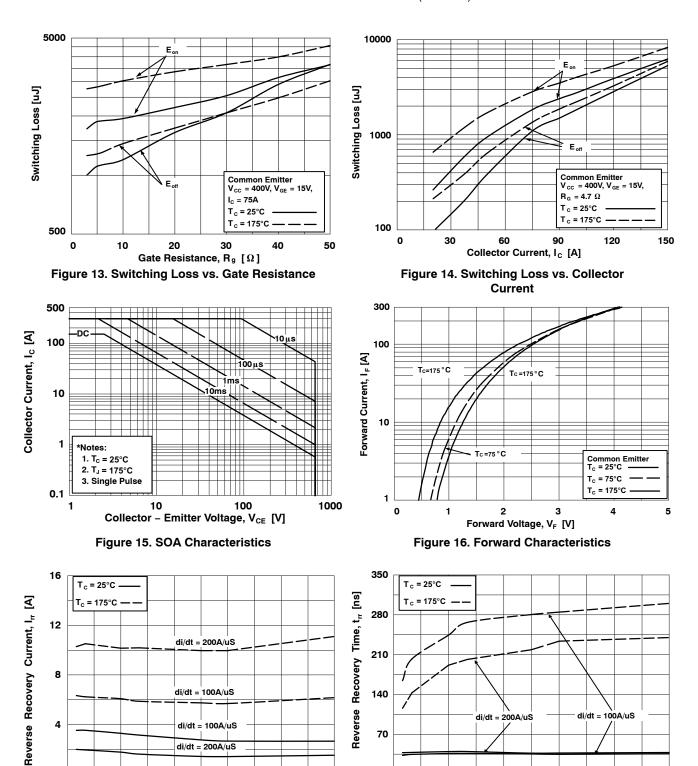


Figure 17. Reverse Recovery Current

Forward Current, V_F [V]

Figure 18. Reverse Recovery Time Stored Charge

Forward Current, V_F [V]

TYPICAL CHARACTERISTICS (continued)

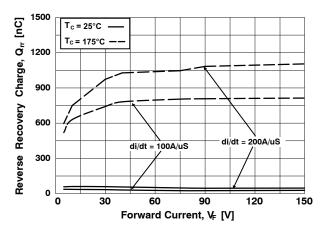


Figure 19. Stored Charge

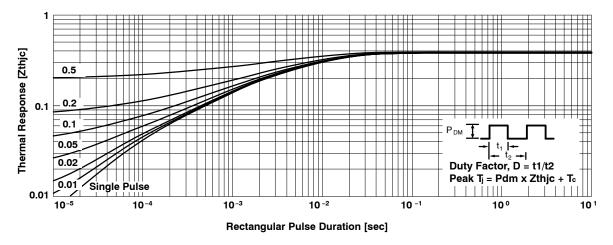


Figure 20. Transient Thermal Impedance of IGBT

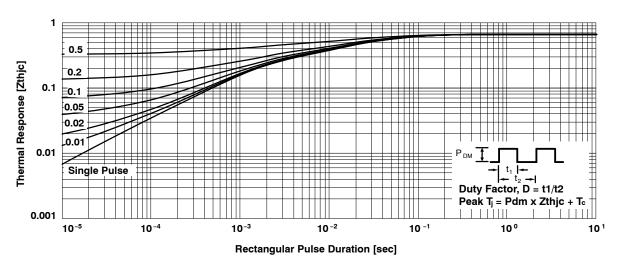
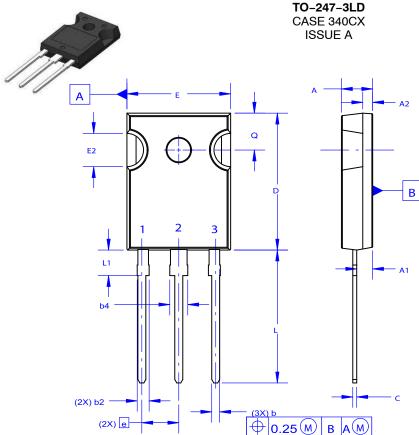
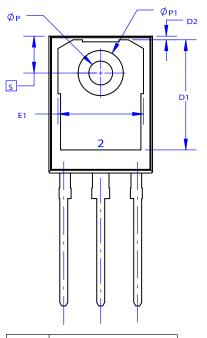


Figure 21. Transient Thermal Impedance of Diode



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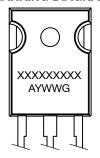


NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MIL	LIMETER	S
DIM	MIN	NOM	MAX
Α	4.58	4.70	4.82
A 1	2.20	2.40	2.60
A2	1.40	1.50	1.60
D	20.32	20.57	20.82
Е	15.37	15.62	15.87
E2	4.96	5.08	5.20
е	~	5.56	~
L	19.75	20.00	20.25
L1	3.69	3.81	3.93
ØΡ	3.51	3.58	3.65
Q	5.34	5.46	5.58
S	5.34	5.46	5.58
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
С	0.51	0.61	0.71
D1	13.08	~	~
D2	0.51	0.93	1.35
E1	12.81	~	~
ØP1	6.60	6.80	7.00

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